February 2007 - Rev 05-Feb-07

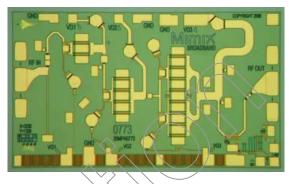
#### Features

- 🗡 Excellent Transmit Output Stage
- ★ Temperature Compensated Output Detector
- ✗ On-Chip ESD Protection
- 🗙 20.0 dB Small Signal Gain
- ★ +28.0 dBm P1dB Compression Point
- ✗ 100% On-Wafer RF, DC and Output Power Testing
- ★ 100% Visual Inspection to MIL-STD-883 Method 2010

#### **General Description**

Mimix Broadband's three stage 17.0-25.0 GHz GaAs MMIC buffer amplifier has a small signal gain of 20.0 dB with a +28.0 dBm P1dB output compression point across the band. The device also includes an on-chip temperature compensated output power detector. This MMIC uses Mimix Broadband's 0.15 µm GaAs PHEMT device model technology, and is based upon electron beam lithography to ensure high repeatability and uniformity. The chip has surface passivation to protect and provide a rugged part with backside via holes and gold metallization to allow either a conductive epoxy or eutectic solder die attach process. This device is well suited for Millimeter-wave Point-to-Point Radio, LMDS, SATCOM and VSAT applications.

#### **Chip Device Layout**



MimiX

**BROADBAND** 

**X P1022-BD** 

# Absolute Maximum Ratings

	Supply Voltage (Vd)	+6.0 VDC
<	Supply Current (ld1,2,3)	145, 290, 580 mA
	Gate Bias Voltage (Vg)	+0.3 VDC
	Input Power (Pin)	+19.0 dBm
	Storage Temperature (Tstg)	-65 to +165 <sup>O</sup> C
	Operating Temperature (Ta)	-55 to MTTF Graph <sup>1</sup>
2	Channel Temperature (Tch)	MTTF Graph <sup>1</sup>

(1) Channel temperature affects a device's MTTF. It is recommended to keep channel temperature as low as possible for maximum life.

# Electrical Characteristics (Ambient Temperature T = 25 °C)

· · · · · · · ·				
Parameter	Units	Min.	Тур.	Max.
Frequency Range (f)	GHz	17.0	-	25.0
Input Return Loss (\$1))	dB	-	9.0	-
Output Return Løss (S22)	dB	-	10.0	-
Small Signal Gain (S21)	dB	-	20.0	-
Gain Flatness ( $\Delta$ S21)	dB	-	+/-2.0	-
Reverse Isolation (S12)	dB	-	50.0	-
Output Power for 1dB Compression (P1dB) <sup>2</sup>	dBm	-	+28.0	-
Drain Bias Voltage (Vd1,2,3) (Vdet)	VDC	-	+5.0	+5.5
Gate Bias Voltage (Vg1,2,3)	VDC	-1.0	-0.7	0.0
Supply Current (Id1) (Vd=5.0V,Vg=-0.7V Typical)	mA	-	100	120
Supply Current (Id2) (Vd=5.0V,Vg=-0.7V Typical)	mA	-	200	240
Supply Current (Id3) (Vd=5.0V,Vg=-0.7V Typical)	mA	-	400	480
Detector (diff) Output at 20 dBm <sup>3</sup>	VDC	-	0.38	-

(2) Measured using constant current.

(3) Measured with Vdet=5.0V

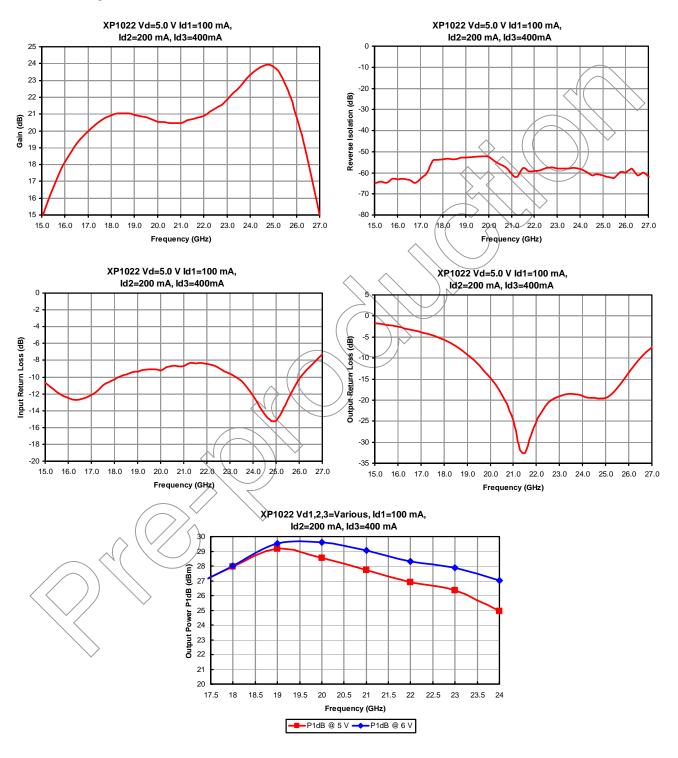
Mimix Broadband, Inc., 10795 Rockley Rd., Houston, Texas 77099 Tel: 281.988.4600 Fax: 281.988.4615 mimixbroadband.com Page 1 of 9

February 2007 - Rev 05-Feb-07

BROADBAND

Mimix

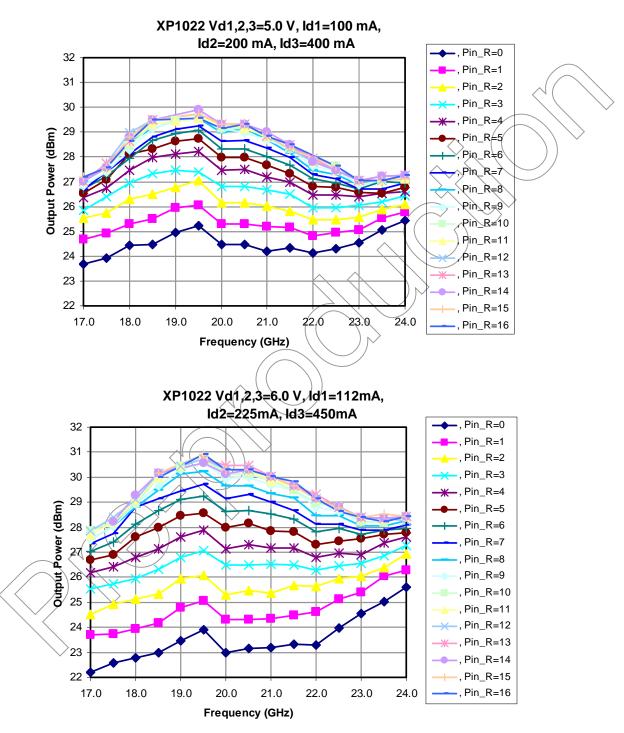
#### **Power Amplifier Measurements**



Mimix Broadband, Inc., 10795 Rockley Rd., Houston, Texas 77099 Tel: 281.988.4600 Fax: 281.988.4615 mimixbroadband.com Page 2 of 9

February 2007 - Rev 05-Feb-07

#### Power Amplifier Measurements (cont.)



Mimix Broadband, Inc., 10795 Rockley Rd., Houston, Texas 77099 Tel: 281.988.4600 Fax: 281.988.4615 mimixbroadband.com Page 3 of 9

February 2007 - Rev 05-Feb-07

#### **S-Parameters**

Typcial S-Parameter Data for XP1022 Vd=5.0 V Id=700 mA

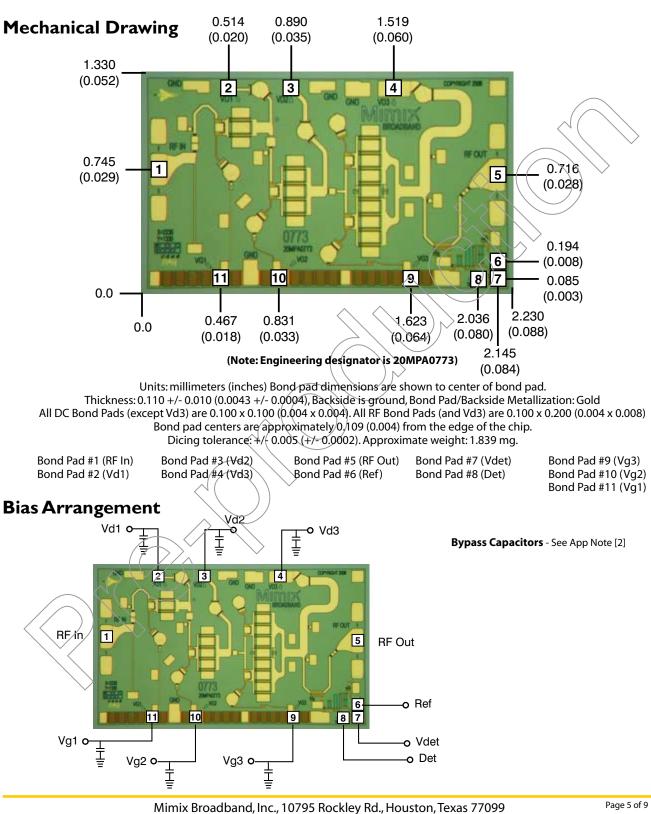
S21 S12 S22 S22 Frequency S11 S11 S21 S12 (GHz) (Mag) (Ang) (Mag) (Ang) (Mag) (Ang) (Mag) (Ang) 0.323 10.0 0.277 139.82 21.12 0.0002 -136.990.932 -36.73 11.0 0.421 134.95 0.839 -51.78 0.0004 -145.34 0.925 -41.28 -162.67 0.921 +46.90 12.0 0.463 118.37 1.354 -116.14 0.0006 13.0 0.440 98.31 2.094 -166.990.0008 -178.300.908 <sup>7</sup>23.90 14.0 0.375 72.94 3.412 143.21 0.0006 151.23 0.879 -62.28 0.292 5.548 0.824 15.0 39.12 88.50 0.0006 155.53 -72.17 0.237 -83.02 16.0 -8.00 8.157 27.93 0.0007 167.67 0.739 17.0 0.248 -57.80 10.017 0.0007 -175.12 0.636 -94.44 -34.68 18.0 0.307 -96.42 11.155 -94.50 0.0021 152.55 0.518 -109.78-152.01 115.10 0.344 -126.56 19.0 0.342 -122.9811.152 0.0023 20.0 0.347 -140.05 10.639 155.81 0.0024 70.14 0.178 -137.44 21.0 0.369 -152.63 10.553 107.90 0.0009 45.90 0.052 -138.07 22.0 0.379 -171.01 11.113 59.09 0.0011 81.27 0.057 -18.94 23.0 0.331 168.03 12.438 8.22 55.37 0.111 -31.38 0.0013 24.0 0.243 129.95 14.706 -50.74 0.0012 39.93 0.112 -57.80 44.25 25.0 0.176 38.36 15.501 -126.00 0.0009 0.106 -115.41 26.0 0.311 -43.15 10.854 148.69 0.0010 42.02 0.218 166.00 27.0 0.434 -72.33 73.31 10.27 0.430 5.509 0.0008 118.83 28.0 0.553 -87.92 2.450 10.18 0.0003 23.03 0.622 86.49 29.0 0.673 -101.09 1.007 -43.72 0.0008 21.06 0.753 61.94 0.770 -112.45 0.393 -88.51 0.0006 -57.54 0.821 42.45 30.0

Mimix Broadband, Inc., 10795 Rockley Rd., Houston, Texas 77099 Tel: 281.988.4600 Fax: 281.988.4615 mimixbroadband.com Page 4 of 9





February 2007 - Rev 05-Feb-07



Tel: 281.988.4600 Fax: 281.988.4615 mimixbroadband.com

February 2007 - Rev 05-Feb-07

BROADBAND

Mimix

**App Note [1] Biasing** - It is recommended to separately bias each amplifier stage Vd1 through Vd3 at Vd(1,2,3)=5.0V with Id1=100mA, Id2=200mA and Id3=400mA. Separate biasing is recommended if the amplifier is to be used at high levels of saturation, where gate rectification will alter the effective gate control voltage. For non-critical applications it is possible to parallel all stages and adjust the common gate voltage for a total drain current Id(total)=700 mA. It is also recommended to use active biasing to keep the currents constant as the RF power and temperature vary; this gives the most reproducible results. Depending on the supply voltage available and the power dissipation constraints, the bias circuit may be a single transistor or a low power operational amplifier, with a low value resistor in series with the drain supply used to sense the current. The gate of the pHEMT is controlled to maintain correct drain current and thus drain voltage. The typical gate voltage needed to do this is -0.7V. Typically the gate is protected with Silicon diodes to limit the applied voltage. Also, make sure to sequence the applied voltage to ensure negative gate bias is available before applying the positive drain supply.

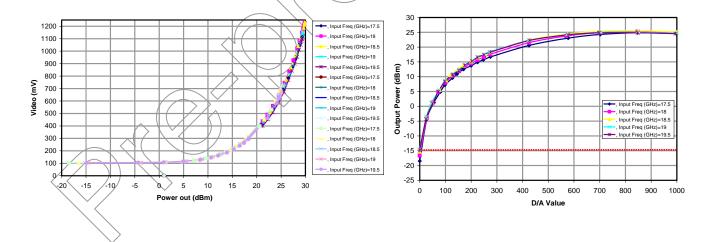
#### App Note [2] Bias Arrangement -

For Parallel Stage Bias (Recommended for general applications) -- The same as Individual Stage Bias but all the drain or gate pad DC bypass capacitors (~100-200 pF) can be combined. Additional DC bypass capacitance (~0.01 uF) is also recommended to all DC or combination (if gate or drains are tied together) of DC bias pads.

For Individual Stage Bias (Recommended for saturated applications) - Each DC pad (Vd1,2,3 and Vg1,2,3) needs to have DC bypass capacitance (~100-200 pF) as close to the device as possible. Additional DC bypass capacitance (~0.01 uF) is also recommended.

App Note [3] On Board Detector – The output signal of the power amplifier is coupled via a 15 dB directional coupler to a detector, which comprises a diode connected to the signal path, and a second diode used to provide a temperature compensation signal. The common bias terminal is Vdet, and is nominally set to forward bias both diodes. The Vdet port can be connected directly to a 5V bias, and given the internal series resistance, results in about 1mA of bias current.

App Note [4] Output Power Adjust Using Drain/Gate Control – This device has a very useful additional feature. The output power can be adjusted by lowering the combined drain voltages and individual or combined gate voltages towards pinch off without sacrificing much in the way of Input/Output 3rd Order Intercept Point. Improvements to the IIP3/OIP3 while attenuating the gain are also possible with individual gate control. Data here has been taken using combined drain and gate control (all gates changed together) to lower the device's output power. The results are shown below. Additionally, the accompanying graph shows the typical level of attenuation achievable as the drain and gate is adjusted at various levels until pinch-off.



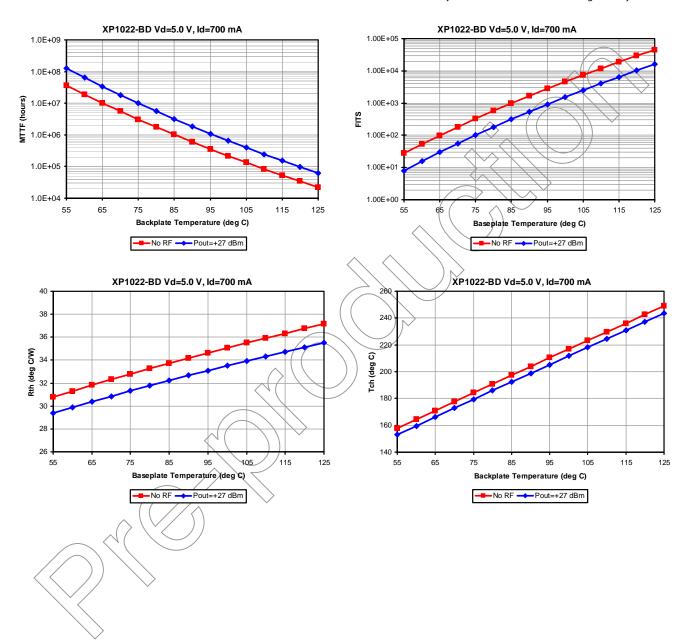
#### Mimix Broadband, Inc., 10795 Rockley Rd., Houston, Texas 77099 Tel: 281.988.4600 Fax: 281.988.4615 mimixbroadband.com

Page 6 of 9

February 2007 - Rev 05-Feb-07

#### MTTF Graphs

These numbers were calculated based on accelerated life test information and thermal model analysis received from the fabricating foundry.



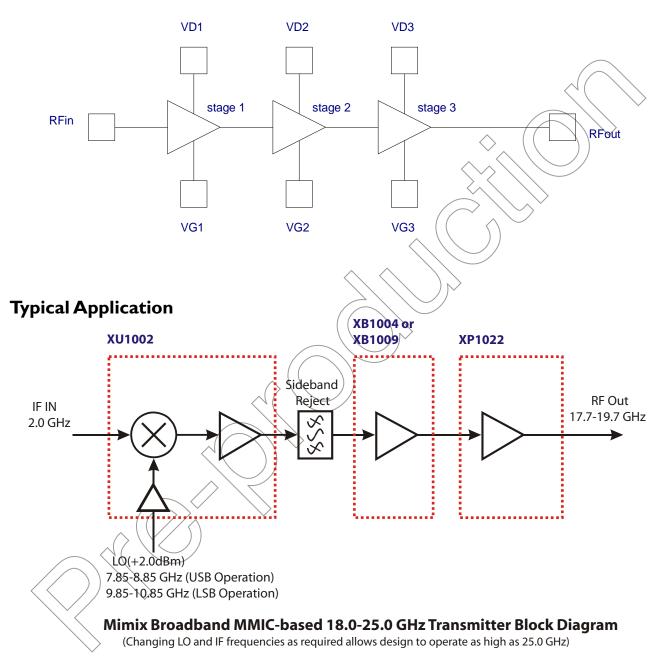
Mimix Broadband, Inc., 10795 Rockley Rd., Houston, Texas 77099 Tel: 281.988.4600 Fax: 281.988.4615 mimixbroadband.com Page 7 of 9



February 2007 - Rev 05-Feb-07



#### **Device Schematic**



Mimix Broadband's 18.0-25.0 GHz XU1002 GaAs MMIC Transmitter can be used in saturated radio applications and linear modulation schemes up to 16 QAM. The transmitter can be used in upper and lower sideband applications from 18.0-25.0 GHz.

Mimix Broadband, Inc., 10795 Rockley Rd., Houston, Texas 77099 Tel: 281.988.4600 Fax: 281.988.4615 mimixbroadband.com Page 8 of 9

February 2007 - Rev 05-Feb-07



#### Handling and Assembly Information

**CAUTION!** - Mimix Broadband MMIC Products contain gallium arsenide (GaAs) which can be hazardous to the human body and the environment. For safety, observe the following procedures:

- Do not ingest.
- Do not alter the form of this product into a gas, powder, or liquid through burning, crushing, or chemical processing as these by-products are dangerous to the human body if inhaled, ingested, or swallowed.
- Observe government laws and company regulations when discarding this product. This product must be discarded in accordance with methods specified by applicable hazardous waste procedures.

Life Support Policy - Mimix Broadband's products are not authorized for use as critical components in life support devices or systems without the express written approval of the President and General Counsel of Mimix Broadband. As used herein: (1) Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user. (2) A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

**ESD** - Gallium Arsenide (GaAs) devices are susceptible to electrostatic and mechanical damage. Die are supplied in antistatic containers, which should be opened in cleanroom conditions at an appropriately grounded anti-static workstation. Devices need careful handling using correctly designed collets, vacuum pickups or, with care, sharp tweezers.

**Die Attachment** - GaAs Products from Mimix Broadband are 0.100 mm (0.004") thick and have vias through to the backside to enable grounding to the circuit. Microstrip substrates should be brought as close to the die as possible. The mounting surface should be clean and flat. If using conductive epoxy, recommended epoxies are Tanaka TS3332LD, Die Mat DM6030HK or DM6030HK-Pt cured in a nitrogen atmosphere per manufacturer's cure schedule. Apply epoxy sparingly to avoid getting any on to the top surface of the die. An epoxy fillet should be visible around the total die periphery. For additional information please see the Mimix "Epoxy Specifications for Bare Die" application note. If eutectic mounting is preferred, then a fluxless gold-tin (AuSn) preform, approximately 0.001 thick placed between the die and the attachment surface should be used. A die bonder that utilizes a heated collet and provides scrubbing action to ensure total wetting to prevent void formation in a nitrogen atmosphere is recommended. The gold-tin eutectic (80% Au 20% Sn) has a melting point of approximately 280 °C (Note: Gold Germanium should be avoided). The work station temperature should be 310 °C +/- 10 °C. Exposure to these extreme temperatures should be kept to minimum. The collet should be heated, and the die pre-heated to avoid excessive thermal shock. Avoidance of air bridges and force impact are critical during placement.

**Wire Bonding** - Windows in the surface passivation above the bond pads are provided to allow wire bonding to the die's gold bond pads. The recommended wire bonding procedure uses 0.076 mm x 0.013 mm (0.003" x 0.0005") 99.99% pure gold ribbon with 0.5-2% elongation to minimize RF port bond inductance. Gold 0.025 mm (0.001") diameter wedge or ball bonds are acceptable for DC Bias connections. Aluminum wire should be avoided. Thermo-compression bonding is recommended though thermosonic bonding may be used providing the ultrasonic content of the bond is minimized. Bond force, time and ultrasonics are all critical parameters. Bonds should be made from the bond pads on the die to the package or substrate. All bonds should be as short as possible.

Part Number for Ordering XP1022-BD-000V XP1022-BD-EV1

#### Description

RoHS compliant die packed in vacuum release gel packs XP1022-BD evaluation module

Mimix Broadband, Inc., 10795 Rockley Rd., Houston, Texas 77099 Tel: 281.988.4600 Fax: 281.988.4615 mimixbroadband.com Page 9 of 9